

Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/033,196		NAKAMURA ET AL.	
				Examiner		Art Unit	
				Jia W. Lu		2634	

ORIGINAL				CROSS REFERENCE(S)									
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)										
375	148	375	147	316									
INTERNATIONAL CLASSIFICATION													
H	0	4	B	1/69									
H	0	4	B	1/707									
H	0	4	B	1/713									
				/									
				/									
Jia Lu 03/10/05 (Assistant Examiner) (Date)				STEPHEN CHIN 3/15/05 SUPERVISORY PATENT EXAMINE TECHNOLOGY CENTER 2800 (Primary Examiner) (Date)								Total Claims Allowed: 11	
John W. Lu 3/20/05 (Legal Instruments Examiner) (Date)												O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R. 1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	31	61	91	121	151	181	
2	32	62	92	122	152	182	
3	33	63	93	123	153	183	
4	34	64	94	124	154	184	
5	35	65	95	125	155	185	
6	36	66	96	126	156	186	
7	37	67	97	127	157	187	
8	38	68	98	128	158	188	
9	39	69	99	129	159	189	
10	40	70	100	130	160	190	
11	41	71	101	131	161	191	
12	42	72	102	132	162	192	
13	43	73	103	133	163	193	
14	44	74	104	134	164	194	
15	45	75	105	135	165	195	
16	46	76	106	136	166	196	
17	47	77	107	137	167	197	
18	48	78	108	138	168	198	
19	49	79	109	139	169	199	
20	50	80	110	140	170	200	
21	51	81	111	141	171	201	
22	52	82	112	142	172	202	
23	53	83	113	143	173	203	
24	54	84	114	144	174	204	
25	55	85	115	145	175	205	
26	56	86	116	146	176	206	
27	57	87	117	147	177	207	
28	58	88	118	148	178	208	
29	59	89	119	149	179	209	
30	60	90	120	150	180	210	